Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,516	FAN ET AL.
Examiner	Art Unit
MINH D. DAO	2618

SEARCHED						
Class	Subclass	Date	Examiner			
455	63.1	11/7/2006	MD			
	67.13					
	570					
	114.2					
	219		_			
	222					
	278.1					
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

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